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**Dear Director Prof. Pavel Neyezhnikov,  
and Dear Colleagues at the NSC Institute of Metrology of The Ukraine**

**Happy World Metrology Day!**

Greetings and best wishes to all of you from your friends and collaborators at the U.S. National Institute of Standards and Technology (NIST)! We hope you and yours are well, as we continue to face the challenges of these times together. Our metrology community is working together globally on the measurement tools and standards for the novel coronavirus response, and in many other related fields in support of healthcare around the world. NIST has a wide range of programs underway as part of the response to this pandemic, as we also continue to deliver our essential functions. We are grateful for the ongoing collaborations with the NSC Institute of Metrology of The Ukraine, and we also wish you and the staff all the best in safely and successfully coming through these challenging times.

On World Metrology Day, we are reminded of the great collaborations that advance science, technology and commerce, and this year we mark the first anniversary of implementing the redefined SI! Our community of metrology will continue to be closely connected through the bonds of friendship, collaboration and development of the standards and solutions that matter – for our people and our respective economies.

**Metrology matters – more than ever.**

With kind regards,  
Walter G. Copan, Ph.D.  
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